

SGH80N60UFD

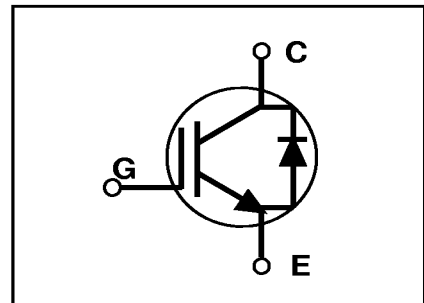
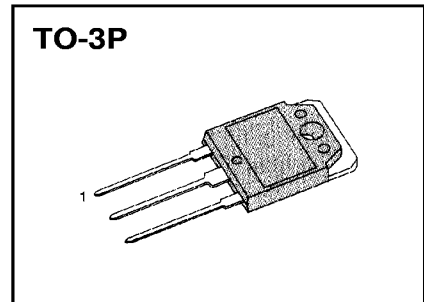
N-CHANNEL IGBT

FEATURES

- * High Speed Switching
- * Low Saturation Voltage
: $V_{CE(sat)} = 2.0\text{ V}$ (@ $I_c=40\text{A}$)
- * High Input Impedance
- * CO-PAK, IGBT with FRD
: $T_{rr} = 50\text{nS}$ (typ.)

APPLICATIONS

- * AC & DC Motor controls
- * General Purpose Inverters
- * Robotics , Servo Controls
- * Power Supply
- * Lamp Ballast



ABSOLUTE MAXIMUM RATINGS

Symbol	Characteristics	Rating	Units
V_{CES}	Collector-Emitter Voltage	600	V
V_{GES}	Gate-Emitter Voltage	± 20	V
I_c	Collector Current @ $T_c = 25^\circ\text{C}$	80	A
	Collector Current @ $T_c = 100^\circ\text{C}$	40	A
$I_{CM(1)}$	Pulsed Collector Current	220	A
I_F	Diode Continuous Forward Current @ $T_c = 100^\circ\text{C}$	25	A
I_{FM}	Diode Maximum Forward Current	280	A
P_D	Maximum Power Dissipation @ $T_c = 25^\circ\text{C}$	195	W
	Maximum Power Dissipation @ $T_c = 100^\circ\text{C}$	78	W
T_j	Operating Junction Temperature	-55 ~ 150	$^\circ\text{C}$
T_{stg}	Storage Temperature Range	-55 ~ 150	$^\circ\text{C}$
T_L	Maximum Lead Temp. For Soldering Purposes, 1/8" from case for 5 seconds	300	$^\circ\text{C}$

Notes:(1) Repetitive rating : Pulse width limited by max. junction temperature



Rev.B

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ELECTRICAL CHARACTERISTICS (IGBT PART)

(T_c=25°C, Unless Otherwise Specified)

Symbol	Characteristics	Test Conditions	Min	Typ	Max	Units	
BV _{CES}	C - E Breakdown Voltage	V _{GE} = 0V , I _C = 250uA	600	-	-	V	
ΔV _{CES} / ΔT _J	Temperature Coeff. of Breakdown Voltage	V _{GE} = 0V , I _C = 1mA	-	0.6	-	V/°C	
V _{GE(th)}	G - E threshold voltage	I _C = 40mA , V _{CE} = V _{GE}	4.5	5.5	7.5	V	
I _{CES}	Collector cutoff Current	V _{CE} = V _{CES} , V _{GE} = 0V	-	-	250	uA	
I _{GES}	G - E leakage Current	V _{GE} = V _{GES} , V _{CE} = 0V	-	-	100	nA	
V _{CE(sat)}	Collector to Emitter saturation voltage	I _C =40A, V _{GE} = 15V	-	2.0	2.6	V	
		I _C =80A, V _{GE} = 15V	-	2.6	-	V	
Cies	Input capacitance	V _{GE} = 0V , f = 1MHz V _{CE} = 30V	-	2790	-	pF	
Co _{es}	Output capacitance		-	347	-	pF	
Cr _{es}	Reverse transfer capacitance		-	96	-	pF	
td(on)	Turn on delay time	V _{CC} = 300V , I _C = 40A V _{GE} = 15V R _G = 5Ω Inductive Load	-	17	-	ns	
tr	Turn on rise time		-	33	-	ns	
td(off)	Turn off delay time		-	97	130	ns	
tf	Turn off fall time		-	70	140	ns	
E _{on}	Turn on Switching Loss		-	0.12	-	mJ	
E _{off}	Turn off Switching Loss		-	0.68	-	mJ	
E _{ts}	Total Switching Loss		-	0.8	1.5	mJ	
Q _g	Total Gate Charge		V _{CC} = 300V	-	178	267	nC
Q _{ge}	Gate-Emitter Charge		V _{GE} = 15V	-	40	60	nC
Q _{gc}	Gate-Collector Charge		I _C = 40A	-	49	74	nC
Le	Internal Emitter Inductance	Measured 5mm from PKG	-	14	-	nH	



ELECTRICAL CHARACTERISTICS (DIODE PART)

(Tc=25°C, Unless Otherwise Specified)

Symbol	Characteristics	Test Conditions		Min	Typ	Max	Units
VFM	Diode Forward Voltage	IF=25A	Tc =25°C	-	1.4	1.7	V
			Tc =100°C	-	1.3	-	
Trr	Diode Reverse Recovery Time	IF=25A, VR=200V -di/dt=200A/μS	Tc =25°C	-	50	75	nS
			Tc =100°C	-	105	-	
Irr	Diode Peak Reverse Recovery Current		Tc =25°C	-	4.5	10	A
			Tc =100°C	-	8.5	-	
Qrr	Diode Reverse Recovery Charge	Tc =25°C	-	112	375	nC	
		Tc =100°C	-	420	-		

THERMAL RESISTANCE

Symbol	Characteristics	Min	Typ	Max	Units
RθJC	Junction-to-Case (IGBT)	-	-	0.64	°C/W
RθJC	Junction-to-Case (DIODE)	-	-	0.83	°C/W
RθJA	Junction-to-Ambient	-	-	40	°C/W
RθCS	Case-to-Sink	-	0.24	-	°C/W

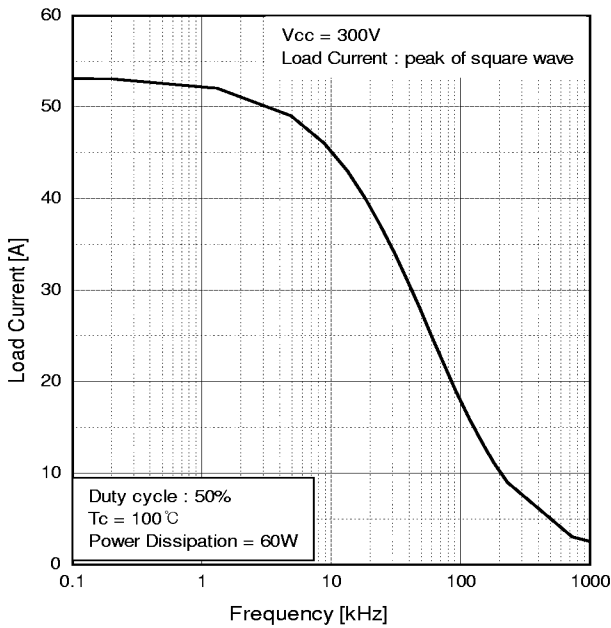


Fig.1 Typical Load Current vs. Frequency

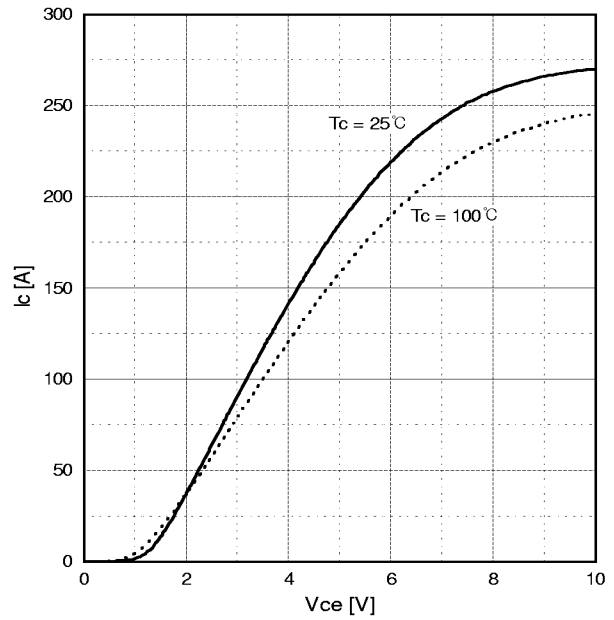


Fig.2 Typical Output Characteristics

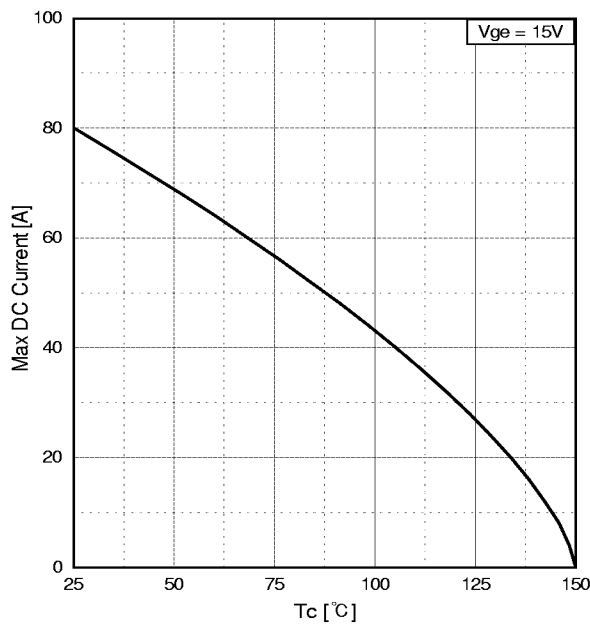


Fig.3 Maximum Collector Current vs. Case Temperature

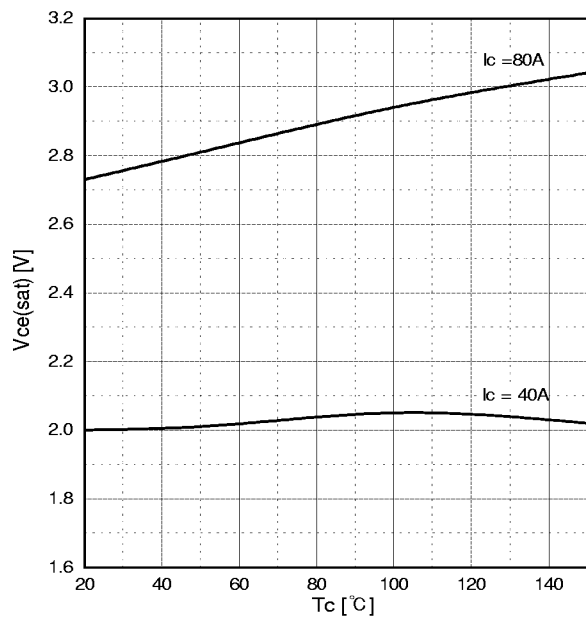


Fig.4 Collector to Emitter Voltage vs. Case Temperature



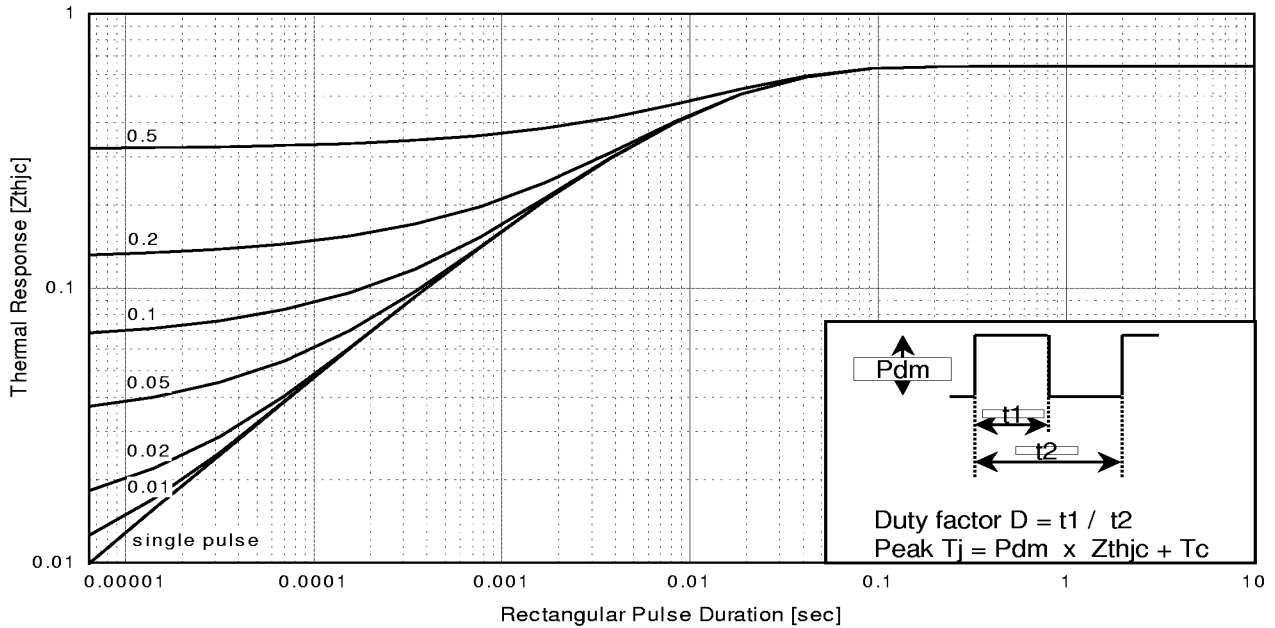


Fig.5 Maximum Effective Transient Thermal Impedance, Junction to Case

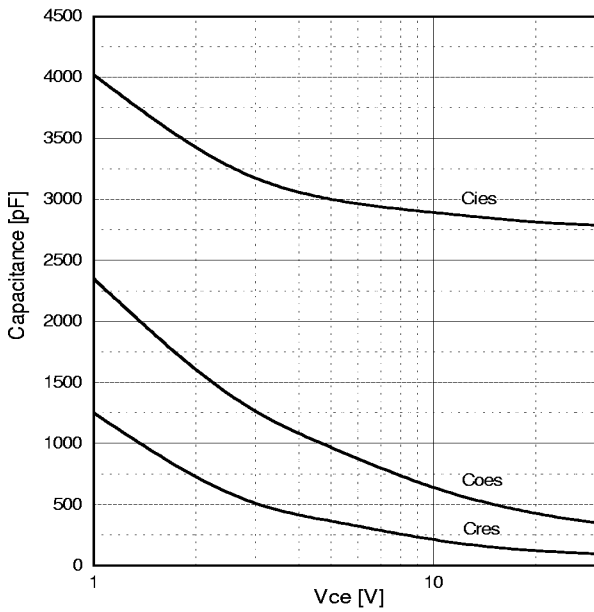


Fig.6 Typical Capacitance vs. Collector to Emitter Voltage

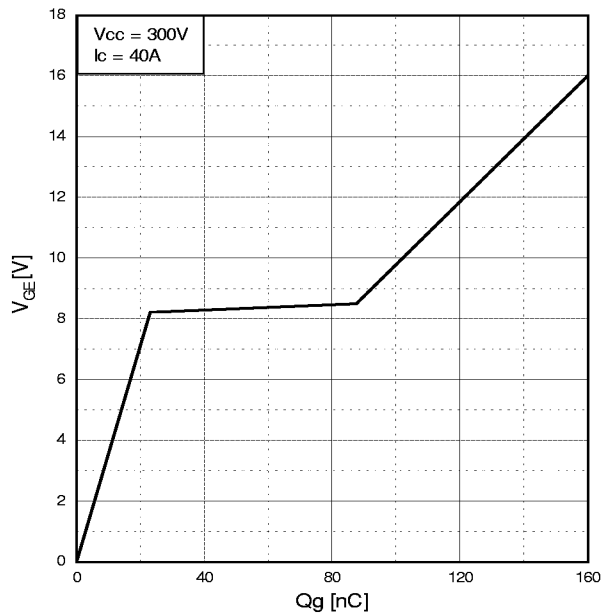


Fig.7 Typical Gate Charge vs. Gate to Emitter Voltage



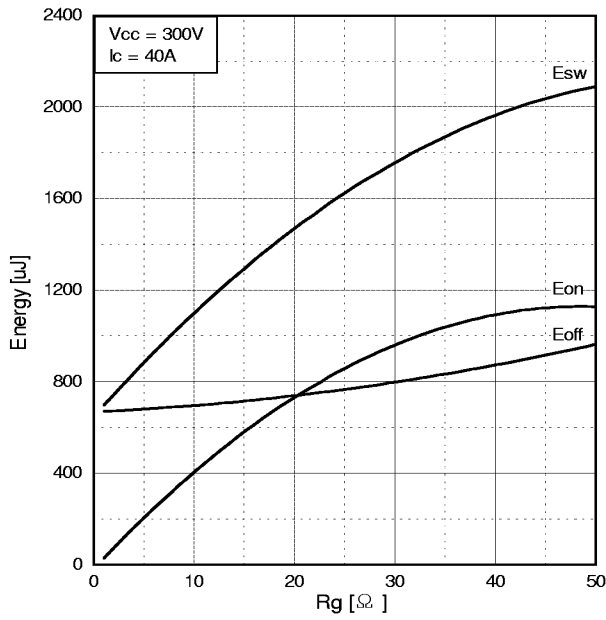


Fig.8 Typical Switching Loss vs. Gate Resistance

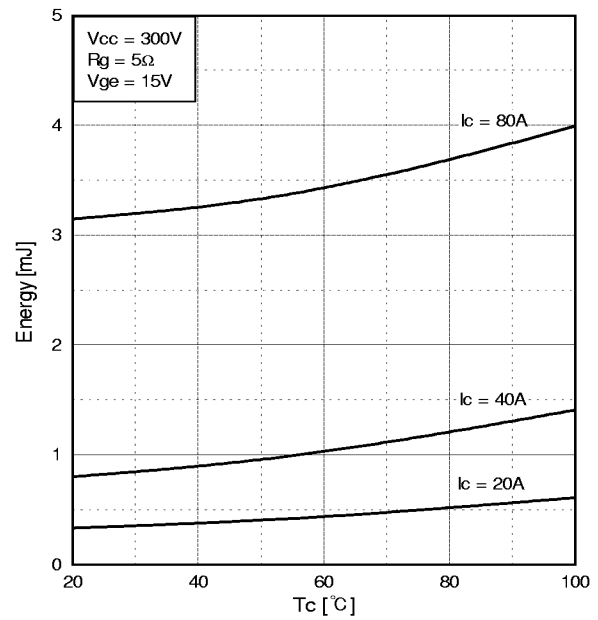


Fig.9 Typical Switching Loss vs. Case Temperature

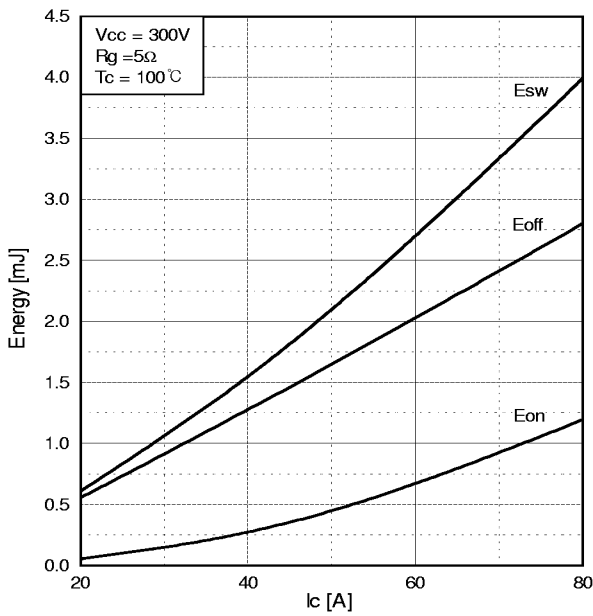


Fig.10 Typical Switching loss vs. Collector to Emitter Current

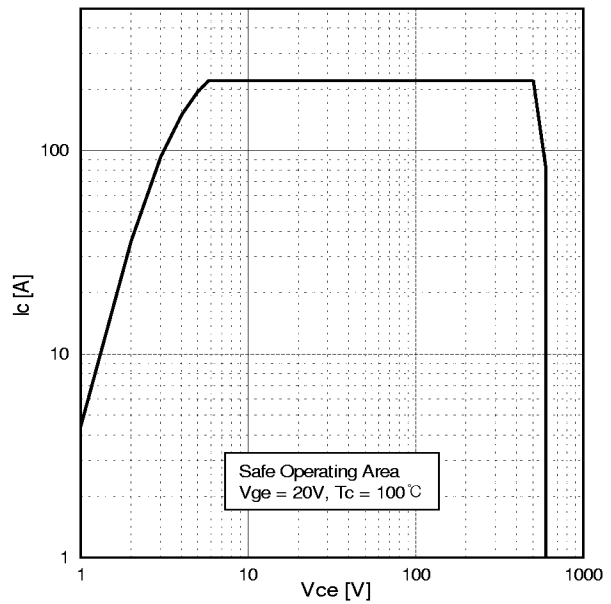


Fig.11 Turn-off SOA



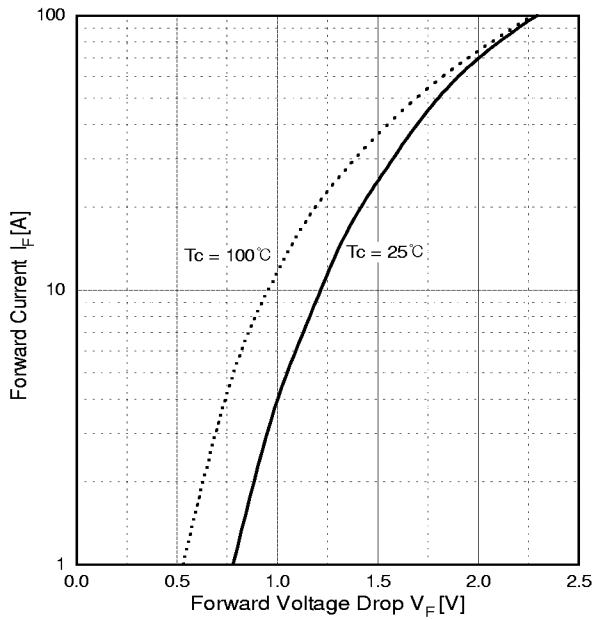


Fig.12 Typical Forward Voltage Drop vs. Forward Current

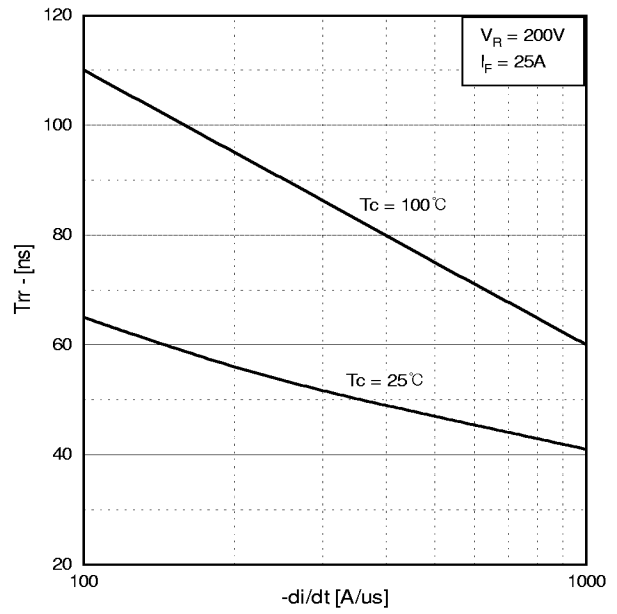


Fig.13 Typical Reverse Recovery Time vs. di/dt

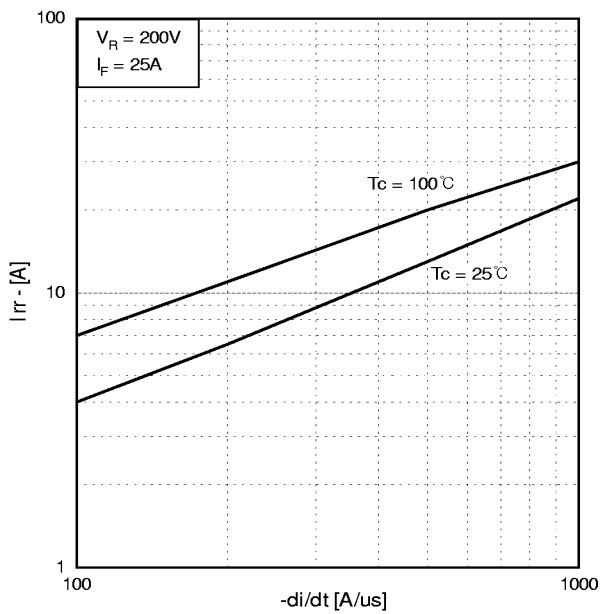


Fig.14 Typical Reverse Recovery Current vs. di/dt

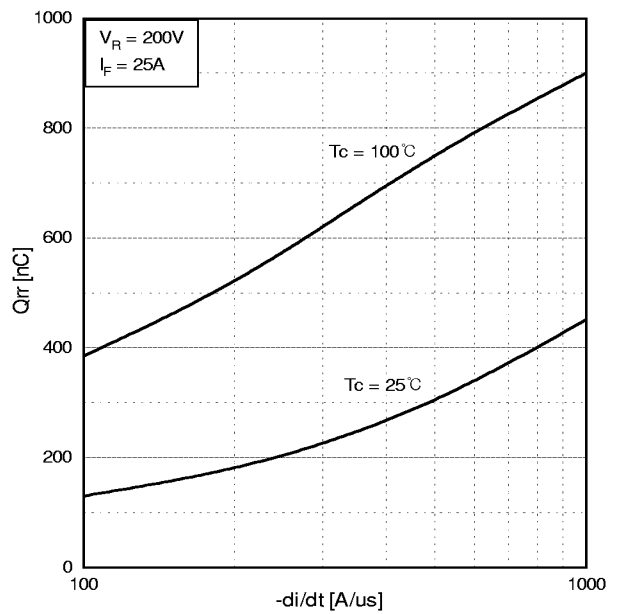


Fig.15 Typical Stored Charge vs. di/dt

